## Notice of References Cited 10/058,103 Reexamination DAIKAI ET AL. Examiner James F. Hook 3752 Reexamination DAIKAI ET AL. Page 1 of 1

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification ,
X	Α	US-5,698,633	12-1997	Matsumoto et al.	525/215
X	В	US-6,745,796	06-2004	Ikemoto et al.	138/126
	С	US-			V
	D	US-			·
	Е	US-			
	F	US-		_	
	G ·	US-			
	Н	US-			
	1	US-	,		
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•				
-	0					
	Р					
	Q					<b>X</b>
	R				•	
	S	· ·				
	٢					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	, V					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under